University of Erlangen-Nuremberg, Germany Department of Computer Science 7 Computer Networks and Communication Systems

Model Driven Testing with Timed Usage Models in the Automotive Domain

Modeling and Test Case Generation

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ISSRE, Bengaluru-Mysuru, India, 2009





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Motivation

- Development of hybrid and electronic vehicles
- Automobiles turn into time-sensitive hybrid systems
- Variability in timing of usage has impact on
 - System behavior
 - Ability of test cases to discover failures
- Exhaustive testing is impossible
- Testing time is scarce and should be used efficiently



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Motivation

Model Driven Testing

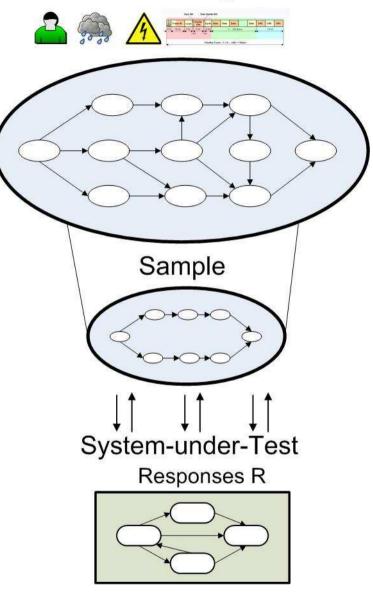
- Classic Markov Chain Usage Models (MCUMs)
- Testing in the Automotive Domain
- Timed Usage Model
 - Semi-Markov Process
 - Computations and Test Planning
 - Test Case Generation
- Case Study
- Conclusion



Model Driven Testing

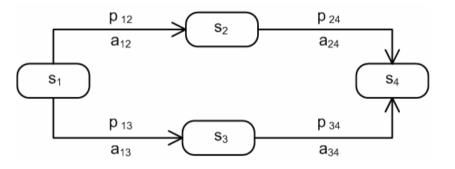
- Usage Model
 - Usage states and transitions
- Test Case Generation
 - Supported by computations
- Computations
 - Expected number of occurences of a state in a test case
 - Long-run probabilities
 - Expected length of a test case in terms of states/transitions

Markov Chain Usage Model



Model Driven Testing

- Markov Chain Usage Model (MCUM):
 - Markov Chain with special characteristics:
 - A set of usage states S = {s₁,...,s_n}.
 - A set of arcs $A = \{a_1, ..., a_n\}$ representing usage state transitions
 - Transition probability p_{ij} from state s_i to s_j
 - One start-state and final state



Problems:

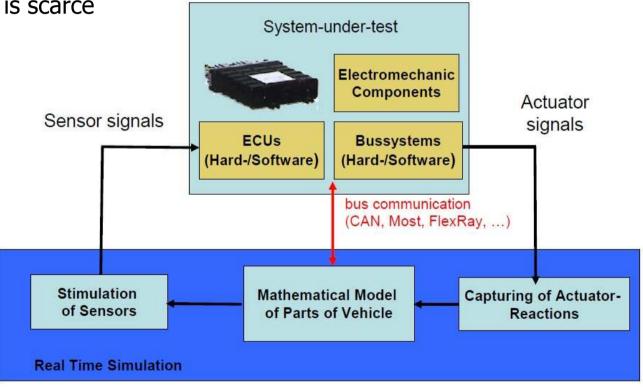
- Each transition = one time unit
- No integration of time
- Timing aspects of requirements not in the model
 - Computations and test case generation need additional data or models to consider time and timing



Testing in Automotive Domain

Execution on Hardware-in-the-loop simulators (HiL)

- SUT feels like being in the real car
- HiLs are expensive
- Testing time is scarce

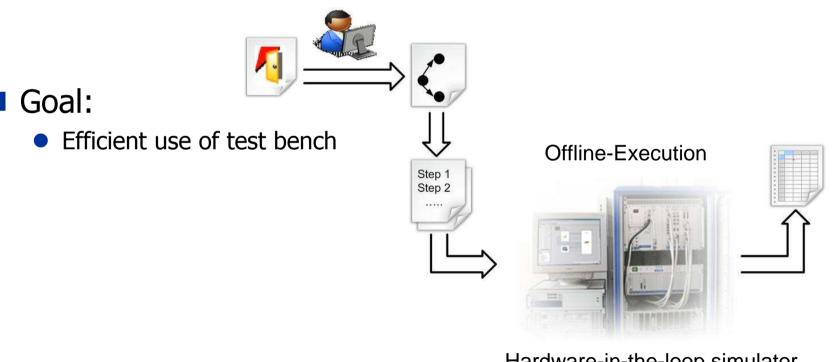




Testing in Automotive Domain

Testing Process

- Test case generation
- Offline execution
 - Hard to estimate testing time



Hardware-in-the-loop simulator





- Motivation
- Model Driven Testing
 - Classic Markov Chain Usage Models (MCUMs)
 - Testing in the Automotive Domain

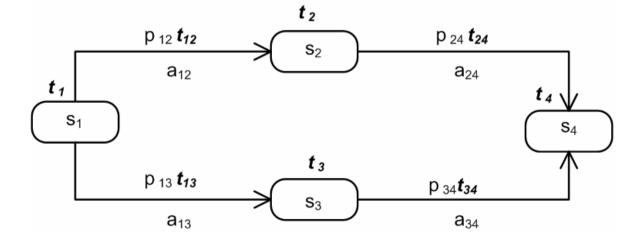
Timed Usage Model

- Semi-Markov Process
- Computations and Test Planning
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Timed Usage Models

- Integration of in timing by new attributes:
 - Sojourn time in usage states: ti, i.e. distribution of time Fi(t)
 - Execution duration of transition: tij, i.e. distribution of time Fij(t)
- Distributions of time exchangeable with usage profiles
 - Distributions for Fi(t) and Fij(t) can be:
 - Deterministic
 - Uniform
 - Bell-shaped
 - Memoryless



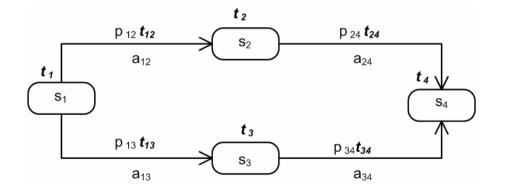


Timed Usage Model

- Integration of non-exponential timing
- Timing variability in usage reflected by model
- Distinction of different user types also possible in timing of usage
 - Exchangeable with usage profiles

Important for:

- System reactions
- non-functional requirements
- Computations and statistics
- Algorithms
- Test case quality

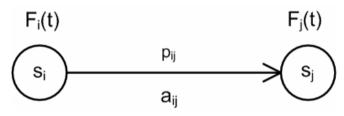




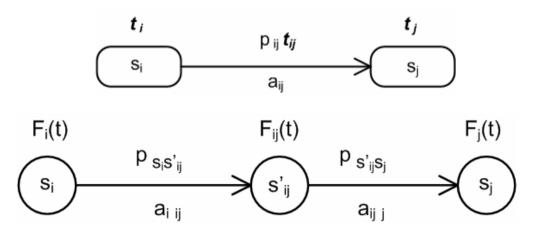
Timed Usage Models

Semi-Markov Process (SMP)

- Change of states according to Discrete Markov Chain
- Random time in states, described by distribution $F_i(t)$



Mapping of elements from Timed Usage Model to SMP



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Timed Usage Models

- Computations on basis of the SMP
 - Execution duration
 - Mean residence time of states and transitions
 - Expected residence time of states and transitions
 - Expected execution time of stimulus
 - ...
- Test case generation from new model
 - Random walk for stimuli and timing
 - Most probable test case in the sense of stimuli and timing
 - Minimal complete arc coverage, combinable with random or boundary values for timing



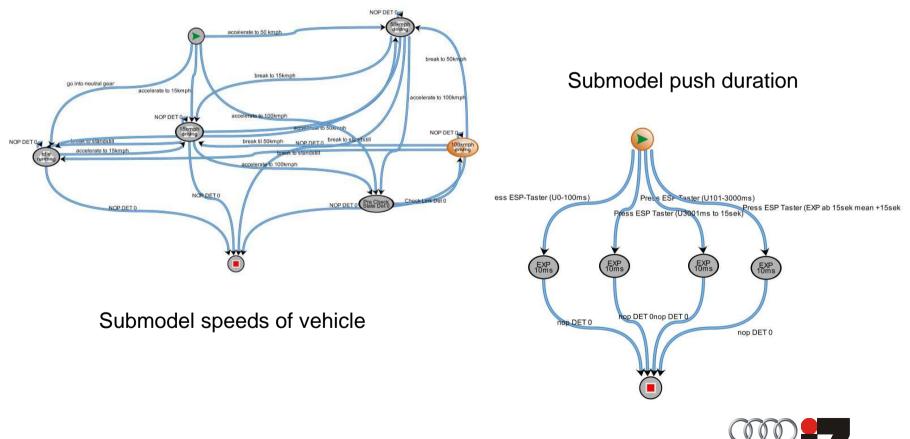
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Case Study



Case study

- Electronic stability program (ESP) operational concept
 - Time sensitive handbag switching mechanism



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Case study

ESP operational concept

Classic computations

New computations

State ID S9998	stat. distrib. 0.04	visit. prob. 1.00	exp # of visits 1.00	State ID	Mean res. time	exp # of visits	exp. res. time
				S9998	0.00	1.00	0.00
S1	0.04	1.00	1.00	S1	9.00	1.00	9.00
S234	0.01	0.22	0.38	S234	10.00	0.38	3.75
S4	0.08	1.00	2.00	S4	0.01	2.00	0.02
S999	0.04	1.00	1.00	S9999	0.00	1.00	0.00



Case study

Issues:

- Determination of proper distribution
- Resolution of time
 - capabilities of test bench
- Impact of data characteristics not considered



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- Time and timing variability in usage model systematically integrated
- Computations become more useful
 - Test effort can be better assessed
 - Test planning is supported
 - Test-bench can be used more efficiently
- Enhanced algorithms for test case generation with timing information
- Currently Timed Usage Models are drawn at AUDI AG for energy management, safety, and air conditioning functionalities



Thank you for listening!

Questions?

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